TRANSMITTAL OF INFORMATION DISCLOSURE STATEMEN (Under 37 C. 1.97(b) or 1.97(c))

Docket No. 02008.073001; AD-0069PCTUS

in Ke	Application	Of: Kouichi WADA et al.	13 Rec'd PCT/I	13 Rec'd PCT/PTO 13 JUN 2002			
Serial No. Filing Date 10/031,823 January 18, 2002		Filing Date January 18, 2002	Examiner	Group Art Unit			
Title:	PROBE C	CARD AND METHOD OF PRODUC	CING THE SAME				
			Address to: Commissioner for Patents shington, D.C. 20231				
		3	37 CFR 1.97(b)				
1. 🛚	The Information Disclosure Statement submitted herewith is being filed within three months of the filing of a national application; within three months of the date of entry of the national stage as set forth in 37 CFR 1.491 in an international application; or before the mailing date of a first Office Action on the merits, whichever event occurs last.						
		3	37 CFR 1.97(c)				
2. 🗖	The Information Disclosure Statement submitted herewith is being filed after three months of the filing of a national application, or the date of entry of the national stage as set forth in 37 CFR 1.491 in an international application; or after the mailing date of a first Office Action on the merits, whichever occurred last but before the mailing date of either:						
	1.	. a Final Action under 37 CFR	R 1.113, or				
	2.	. a Notice of Allowance under	37 CFR 1.311,				
	w	hichever occurs first.					
	Also subn	nitted herewith is:					
	☐ a certification as specified in 37 CFR 1.97(e);						
		OR					
		e fee set forth in 37 CFR 1.17(p) der 37 CFR 1.97(c).	for submission of an Information Disc	closure Statement			
			<i>)</i>				

TRANSMITTAL OF	Docket No. 02008.073001; AD-0069PCTUS							
In Re Application Of: Kouichi WADA et al.								
Serial No. 10/031,823	Group Art Unit							
Title: PROBE CARD A	AND METHOD OF PRODUCING	THE SAME						
	,							
	Payment of Fee (Only complete if Applicant elects to pay the fee set forth in 37 CFR 1.17(p))							
A check in the amount of is attached. The Assistant Commissioner is hereby authorized to charge and credit Deposit Account No. 50-0591 as described below. A duplicate copy of this sheet is enclosed. Charge the amount of Credit any overpayment. Charge any additional fee required. Certificate of Transmission by Facsimile* Certificate of Transmission by Facsimile* Certificate of Mailing by First Class Mail certify that this document and authorization to charge deposit account is being facsimile transmitted to the United States Patent and Trademark Office (Fax. No.) On the Commission of Patents, Weshington, D.C. Signature Typed or Printed Name of Person Signing Certificate This certificate may only be used if paying by deposit account. Signature of Printed Name of Person Mailing Correspondence Typed or Printed Name of Person Mailing Correspondence Dated: 6/3/02 Jonathant P. Osha, Reg. No. 33,986 ROSENTHAL & OSHA L.L.P. 1221 McKinney Ave., Suite 2800 Houston, TX 77010 Tel: (713) 228-8600 Fax: (713) 228-86778								
сс:								

P10A/REV01

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CERTIFICATE OF Applicant(s): Kouichi W	MAILIN "EXPRESS I	ESS MAIL" (37 CFR 1.1		Docket No. 02008/073001; AD-0069PCTUS	
Serial No. 10/031,823	Filing Date January 18, 2002	Examiner		Group Art Unit	
Invention: PROBE CAL	RD AND METHOD OF PRODUC	CING THE SAME			
I hereby certify that this	s Information Dislosure Statem	ent (Identify type of correspondence)			
is being deposited with	n the United States Postal Servi	ce "Express Mail Post Office	to Add	lressee" service under	
37 CFR 1.10 in an en	velope addressed to: The Com	missioner of Patents and Tra	adema	rks, Washington, D.C.	
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Related Art(s) for Information Disclosure

Your Ref.

Our Ref. AD-0069PCTUS

RE (Title) PROBE CARD AND A METHOD FOR MANUFACTURING THEREOF

List of Attached Document(s)

- 1. Document(s) discussed in the specification of the present Patent Application or written in English
 - (1) US patent No. 5,613,861
 - (2) Donald L. Smith, et. Al., in their "Flip-Chip Bonding on 6-um Pitch using Thin-Film Microspring Technology" ((Proceedings of 48th Electronic Components and Technology Conf.; Seattle, Washington (May, 1998):c1998 IEEE)
 - (3) Soonil Hong, et. Al., in their "DESIGN AND FABRICATION OF A MONOLITHIC HIGH-DENSITY PROBE CARD FOR HIGH-FREQUENCY ON-WATER TESTING" (IEDM 89, pp.289-292)
 - (4) Yanwei Zhang, et. Al., in their "A NEW MEMS WAFER PROBE CARD" (0-7803-3744-1/97 IEEE, pp.395-399)
 - (5) Shinichiro Asai, et. Al., in their "Probe Card with Probe Pins Grown by the Vapor-Liquid-Solid(VLS) Method" (IEEE TRANSACTIONS ON COMPONENTS, PACKAGING AND MANUFACTURING TECHNOLOGY-PART A, VOL.19, NO.2, JUNE 1996)
- 2. Other Document(s) (with concise explanation regarding the relevancy)

INFORMATION DISCLOSURE TATION

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Kouichi WADA et a	

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					FILING January 18	GROUP				
				U.S	S. PATENT	DOCUMENTS				,
EXAMINER			DOCUMENT NUMBER	DATE	NAME Smith et al.		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE 06/07/1995	
	A1	5,613	13,861	03/25/1997			439	81		
				FORE	IGN PATE	NT DOCUMENTS				
			DOCUMENT NUMBER	CUMENT NUMBER DATE		COUNTRY	CLASS	SUBCLASS	TRANSLATION	
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	<u> </u>		OTHER DOCUM	INTS (Includir	g Authoi	r, Title, Date, Pertin	ent Pages. Etc.)	<u></u>	L
		A2	Donald L. Smith et al., 48th Electronic Compo						roceedings of the second secon	of the pages

Soonil Hong et al., "DESIGN AND FABRICATION OF A MONOLITHIC HIGH-DENSITY PROBE CARD FOR HIGH-FREQUENCY ON-WATER TESTING," IEDM 89, pp. 289-292 (4 pages)

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

SERIAL NO. ATTY DOCKET NO. 02008.073001; AD-0069PCTUS 10/031,823 INFORMATION DISCLOSURE TATION Kouichi WADA et a (Use several sheets if neces GROUP FILING January 18, 2002 **U.S. PATENT DOCUMENTS** FILING DATE *EXAMINER CLASS SUBCLASS DOCUMENT NUMBER DATE NAME IF APPROPRIATE INITIAL **FOREIGN PATENT DOCUMENTS** TRANSLATION COUNTRY CLASS SUBCLASS DOCUMENT NUMBER DATE YES NO **OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

Yanwei Zhang et al.; "A NEW MEMS WAFER PROBE CARD," 0-7803-3744-1/97 IEEE, pp. 395-399 (5 pages)

Shinichiro Asai et al.; "Probe Card with Probe Pins Grown by the Vapor-Liquid-Solid(VLS) Method;" IEEE Transactions on Components, PACKAGING AND MANUFACTURING TECHBNOLOGY-Part A, Vol. 19, No. 2, June 1996; pp. 258-267

EXAMINER DATE CONSIDERED

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(10 pages)